

Notice of References Cited	Application/Control No. 10/623,286	Applicant(s)/Patent Under Reexamination FINN ET AL.	
	Examiner Devona E. Faulk	Art Unit 2615	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,442,712	08-1995	Kawamura et al.	381/83
*	B	US-2004/0158460	08-2004	Finn et al.	704/205
*	C	US-6,252,969	06-2001	Ando, Shigeo	381/103
*	D	US-6,125,187	09-2000	Hanajima et al.	381/83
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FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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